

<b>Notice of References Cited</b>		Application/Control No. 10/577,670	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
		Examiner JOSEPH DEAN, JR	Art Unit 2617	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0036810 A1	11-2001	Larsen, James David	455/11.1
*	B	US-2003/0156558 A1	08-2003	Cromer et al.	370/331
*	C	US-2004/0219878 A1	11-2004	Raji, Vijaye G.	455/011.1
*	D	US-7,095,722 B1	08-2006	Walke et al.	370/315
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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